

<b>Notice of References Cited</b>	Application/Control No. 10/346,771	Applicant(s)/Patent Under Reexamination SATARDJA	
	Examiner Alexander O Williams	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,507,115 B2	01-2003	Hofstee et al.	257/777
	B	US-5,424,573	06-1995	Kato et al.	257/431
	C	US-2002/0195270 A1	12-2002	Okubora et al.	174/260
	D	US-5,311,402	05-1994	Kobayashi et al.	361/760
	E	US-6,421,473 B1	07-2002	Paniccia et al.	385/14
	F	US-2003/0021568 A1	01-2003	Samara-Rubio et al.	385/132
	G	US-6,388,207 B1	05-2002	Figuroa et al.	174/262
	H	US-2002/0071256 A1	06-2002	Figuroa et al.	361/763
	I	US-2002/0195700 A1	12-2002	Li, Yuan-Liang	257/700
	J	US-2002/0196898 A1	12-2002	Kameshima, Toshio	378/98.8
	K	US-2003/0016133 A1	01-2003	Egbert, William C.	340/572.7
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	08-250652	02-1996	Japan	Degani et al.	
	O	62-281435	12-1987	Japan	Otsuka et al.	
	P	60-154648	08-1985	Japan	Shirai et al.	
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.